

<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/774,685	YAMANAKA ET AL.
	Examiner Wei Y. Zhen	Art Unit 2191

ORIGINAL			CROSS REFERENCE(S)									
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
717	140	/										
INTERNATIONAL CLASSIFICATION			G 06 F 9/45	/	/	/	/	/	/	/	/	
(Assistant Examiner) (Date)			WEI Y. ZHEN PRIMARY EXAMINER (Primary Examiner) 9/29/05 (Date)								Total Claims Allowed: 18	
Jedone D. (Legal Instruments Examiner) (Date)			M.Y.Z. (Signature)								O.G. Print Claim(s) /	O.G. Print Fig. 3

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant	<input type="checkbox"/> CPA	<input type="checkbox"/> T.D.	<input type="checkbox"/> R.1.47
Final 1 Original 1	Final 31 Original 61	Final 91 Original 121	Final 151 Original 181
2 2	32 62	92	152
3 3	33 63	93	153
4 4	34 64	94	154
5 5	35 65	95	155
6 6	36 66	96	156
7 7	37 67	97	157
8 8	38 68	98	158
9 9	39 69	99	159
10 10	40 70	100	160
11 11	41 71	101	161
12 12	42 72	102	162
13 13	43 73	103	163
14 14	44 74	104	164
15 15	45 75	105	165
16 16	46 76	106	166
17 17	47 77	107	167
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